

Search Notes

Application/Control No.

10/071,353

Examiner

Ali Bayat

Applicant(s)/Patent under
Reexamination

TAKANO ET AL.

Art Unit

2625

SEARCHED

Class	Subclass	Date	Examiner
382	162,167,2 74	4/26/2005	A.B
358	518-527	4/26/2005	A.B
345	589-591	4/26/2005	A.B
345	593,601	4/26/2005	A.B
345	604	4/26/2005	A.B
348	807,496	4/26/2005	A.B
348	188,453	4/26/2005	A.B
348	223.1	4/26/2005	A.B

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
382	167,274	4/26/2005	A.B
358	518,523	4/26/2005	A.B
348	188,223.1	4/26/2005	A.B

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST; US_PGPUB;USPAT;EPO;JPO;DERW ENT;IBM_TDB; IEEE.	4/26/2005	A.B